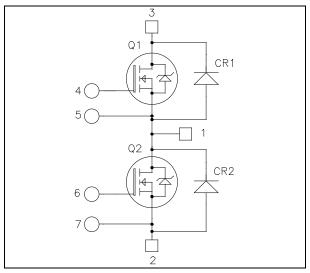
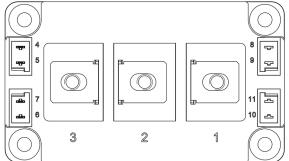


### APTMC120AM16CD3AG

### Phase leg SiC MOSFET Power Module

 $V_{DSS} = 1200V$   $R_{DSon} = 16m\Omega \text{ typ } @ \text{Tj} = 25^{\circ}\text{C}$   $I_D = 98A @ \text{Tc} = 25^{\circ}\text{C}$ 





#### Application

- Welding converters
- Switched Mode Power Supplies
- Uninterruptible Power Supplies
- Motor control

#### **Features**

- SiC Power MOSFET
  - High speed switching
  - Low R<sub>DS(on)</sub>
  - Ultra low loss

#### • SiC Schottky Diode

- Zero reverse recovery
- Zero forward recovery
- Temperature Independent switching behavior
- Positive temperature coefficient on VF
- Kelvin emitter for easy drive
- High level of integration
- AlN substrate for improved thermal performance
- M6 power connectors

#### **Benefits**

- Stable temperature behavior
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- RoHS Compliant

#### All ratings @ $T_i = 25$ °C unless otherwise specified

#### Absolute maximum ratings (per SiC MOSFET)

Symbol	Parameter		Max ratings	Unit
$V_{ m DSS}$	Drain - Source Voltage		1200	V
ī	Continuous Drain Current	$T_c = 25^{\circ}C$	131	
$I_D$	Continuous Diam Current	$T_c = 80^{\circ}C$	98	A
$I_{DM}$	Pulsed Drain current		262	
$V_{GS}$	Gate - Source Voltage		-10/25V	V
R <sub>DSon</sub>	Drain - Source ON Resistance		20	$m\Omega$
$P_{D}$	Maximum Power Dissipation	$T_c = 25^{\circ}C$	625	W

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com

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### **Electrical Characteristics** (per SiC MOSFET)

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{GS} = 0V$ , $V_{DS} = 120$			500	μA	
D	Drain – Source on Resistance	$V_{GS} = 20V$	$T_j = 25^{\circ}C$		16	20	
$R_{DS(on)}$		$I_{\rm D} = 100 A$	$T_{j} = 150^{\circ}C$		30	42	mΩ
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 5mA$		1.7	2.2		V
$I_{GSS}$	Gate – Source Leakage Current	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$				1.25	μA

#### **Dynamic Characteristics** (per SiC MOSFET)

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
$C_{iss}$	Input Capacitance	$V_{GS} = 0V$ $V_{DS} = 1000V$			4.75		
$C_{oss}$	Output Capacitance				0.4		nF
$C_{rss}$	Reverse Transfer Capacitance	f = 1MHz		0.033			
$Q_{g}$	Total gate Charge	$V_{GS} = 0/+20V$			246		
$Q_{gs}$	Gate – Source Charge	$V_{Bus} = 800V$			54		nC
$Q_{gd}$	Gate – Drain Charge	$I_{\rm D} = 100 A$		90			
$T_{d(on)}$	Turn-on Delay Time	$V_{GS} = -5/+20V$		20			
$T_{\rm r}$	Rise Time	$V_{\text{GS}} = 37/20 \text{ V}$ $V_{\text{Bus}} = 800 \text{ V}$		20			
$T_{d(off)}$	Turn-off Delay Time	- , ,	$I_D = 100A$ ; $T_J = 150$ °C $R_L = 8\Omega$ ; $R_{Gext} = 10\Omega$				ns
$T_{\mathrm{f}}$	Fall Time	$R_L = 8\Omega$ ; $R_{Gext} = 108$					
Eon	Turn on Energy	Inductive Switching $V_{GS} = -5/+20V$ $V_{Bus} = 600V$	$T_j = 150$ °C		2.2		mJ
$E_{\text{off}}$	Turn off Energy	$I_D = 100A$ $R_{Gext} = 10\Omega$ $T_j = 150^{\circ}C$			1.25		1113
$R_{Gint}$	Internal gate resistance				1.9		Ω
$R_{\text{thJC}}$	Junction to Case Thermal Resistance	e				0.20	°C/W

#### **Source - Drain diode ratings and characteristics** (per SiC MOSFET)

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit
$V_{\mathrm{SD}}$	Diode Forward Voltage	$V_{GS} = -5V, I_{SD} = 50A$		3.3		V
		$V_{GS} = -2V, I_{SD} = 50A$		3.1		V
t <sub>rr</sub>	Reverse Recovery Time	$I_{SD} = 100A$ ; $V_{GS} = -5V$ $V_{R} = 800V$ ; $di_{F}/dt = 1750A/\mu s$		40		ns
Q <sub>rr</sub>	Reverse Recovery Charge			825		nC
$I_{rr}$	Reverse Recovery Current	V <sub>R</sub> 800 V, αι <sub>Γ</sub> /αι 1730 A/μs		32		Α



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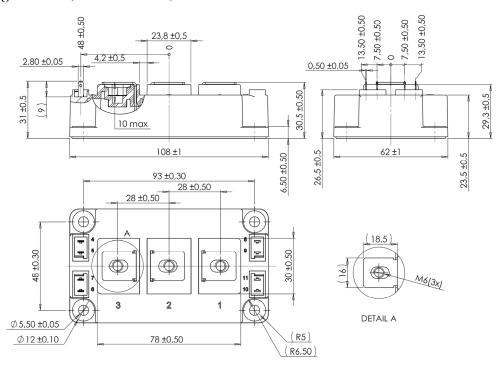
#### SiC schottky diode ratings and characteristics (per SiC diode)

Symbol	Characteristic	Test Condition	Test Conditions			Max	Unit
$V_{RRM}$	Peak Repetitive Reverse Voltage					1200	V
T	Boyanga Laakaga Cumment	V <sub>R</sub> =1200V	$T_j = 25$ °C		192	1200	4
$I_{RRM}$	Reverse Leakage Current	$\mathbf{v}_{\mathrm{R}}$ -1200 $\mathbf{v}_{\mathrm{R}}$	$T_j = 175$ °C		336	6000	μA
$I_F$	DC Forward Current		Tc = 125°C		60		A
V	$V_F$ Diode Forward Voltage $I_F = 60A$	I_ = 60 A	$T_i = 25$ °C		1.6	1.8	V
<b>V</b> F		I <sub>F</sub> = 00A	$T_i = 175$ °C		2.3	3	V
$Q_{C}$	Total Capacitive Charge	,	$I_F = 60A, V_R = 1200V$ di/dt = 2400A/ $\mu$ s				nC
С	Total Capacitance	$f = 1MHz, V_R =$	$f = 1MHz, V_R = 200V$		576		pF
	Total Capacitance	$f = 1MHz, V_R =$	$f = 1 MHz, V_R = 800V$		414		pr
$R_{thJC}$	Junction to Case Thermal Resistance	ction to Case Thermal Resistance				0.19	°C/W

#### Thermal and package characteristics

Symbol	Characteristic					Max	Unit	
$V_{ISOL}$	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz						V	
$T_{J}$	Operating junction temperature range  SiC MOSFET SiC diode		SiC	C MOSFET	-40	150		
1 J			-40	175				
$T_{JOP}$	Recommended junction temperature under switching conditions					T <sub>J</sub> max -25	°C	
$T_{STG}$	Storage Temperature Range					125	1	
$T_{\rm C}$	Operating Case Temperature					100		
Torque	Maynting targue	For termin	als	M6	3	5	N.m	
Torque	Mounting torque To Heatsi		nk	M6	3	5	11.111	
Wt	Package Weight		•			350	g	

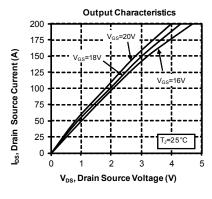
#### D3 Package outline (dimensions in mm)

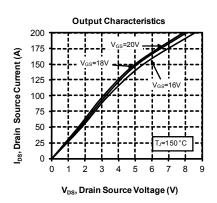


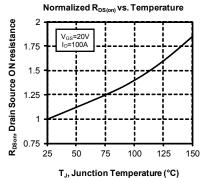
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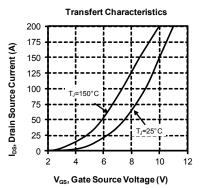


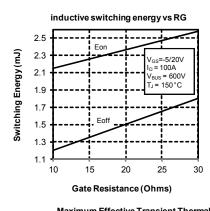
#### **Typical SiC MOSFET Performance Curve**

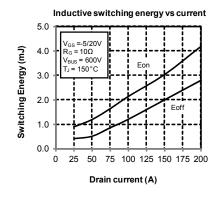


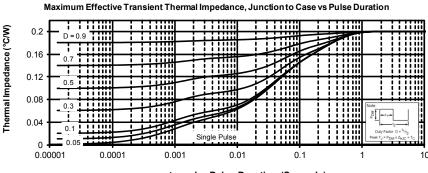










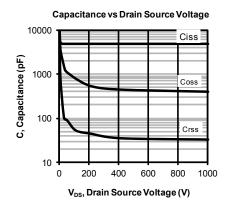


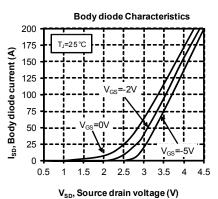
rectangular Pulse Duration (Seconds)

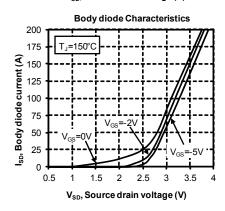
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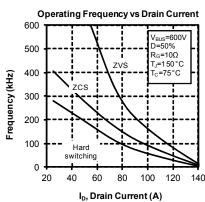


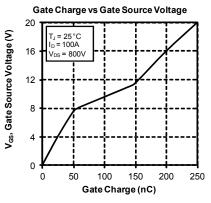
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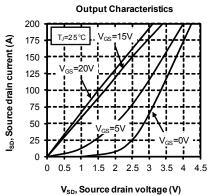


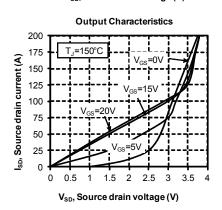










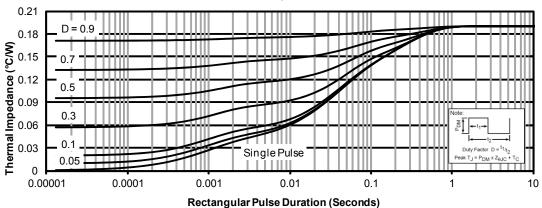


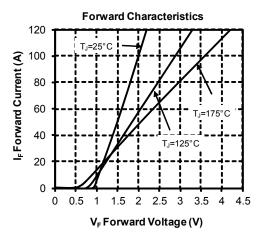


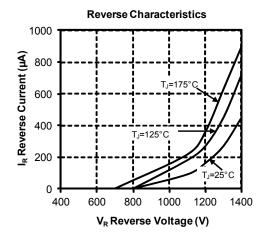
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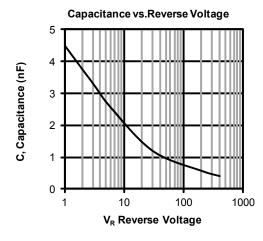
#### **Typical SiC diode Performance Curve**

#### Maximum Effective Transient Thermal Impedance, Junction to Case vs Pulse Duration









### APTMC120AM16CD3AG

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